# **Power MOSFET**

# 30 V, 23 A, Single N-Channel, SO-8 Flat Lead

#### **Features**

- Low R<sub>DS(on)</sub>
- Low Inductance SO-8 Package
- These are Pb-Free Devices

## **Applications**

- Notebooks, Graphics Cards
- DC-DC Converters
- Synchronous Rectification

## MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V <sub>DSS</sub>	30	V
Gate-to-Source Voltage			V <sub>GS</sub>	±20	V
Continuous Drain Current	Steady	T <sub>A</sub> = 25°C	I <sub>D</sub>	14	Α
(Note 1)	State	T <sub>A</sub> = 85°C		10	
	t ≤10 s	T <sub>A</sub> = 25°C		23	
Power Dissipation (Note 1)	Steady State	T <sub>A</sub> = 25°C	P <sub>D</sub>	2.2	W
	t ≤10 s			5.8	
Continuous Drain Current	T <sub>A</sub> = 25°C		I <sub>D</sub>	9.1	Α
(Note 2)	Steady State	T <sub>A</sub> = 85°C		6.5	
Power Dissipation (Note 2)		T <sub>A</sub> = 25°C	$P_{D}$	0.9	W
Pulsed Drain Current	t <sub>p</sub> =	10 μs	I <sub>DM</sub>	68	Α
Operating Junction and Storage Temperature			T <sub>J</sub> , T <sub>stg</sub>	–55 to 150	°C
Source Current (Body Diode)			I <sub>S</sub>	7.0	Α
Single Pulse Drain-to-Source Avalanche Energy ( $V_{DD}$ = 30 V, $V_{GS}$ = 10 V, $I_{PK}$ = 21 A, L = 1 mH, $R_G$ = 25 $\Omega$ )			E <sub>AS</sub>	220	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T <sub>L</sub>	260	°C

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	56.3	°C/W
Junction-to-Ambient - t ≤ 10 s (Note 1)	$R_{\theta JA}$	21.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	141.6	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

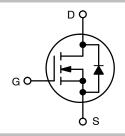
- Surface mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces).
- Surface mounted on FR4 board using the minimum recommended pad size (Cu area = 0.0264 in sq).



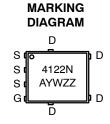
## ON Semiconductor®

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> TYP	I <sub>D</sub> MAX (Note 1)
30 V	4.6 mΩ @ 10 V	23 A
00 V	6.3 mΩ @ 4.5 V	2074







4122N = Specific Device Code A = Assembly Location

Y = Year W = Work Week ZZ = Lot Traceability

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NTMFS4122NT1G	SO-8 FL (Pb-Free)	1500 Tape & Reel
NTMFS4122NT3G	SO-8 FL (Pb-Free)	5000 Tape & Reel

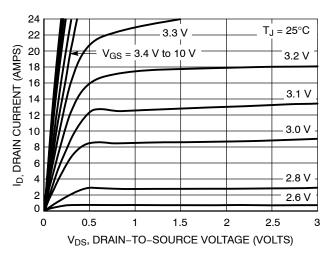
†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Characteristic	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•				<u>-</u>	<u>-</u>	-
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				23		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V 0VV 04V	$T_J = 25^{\circ}C$			1.0	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	$I_{GSS}$	$V_{DS} = 0 V, V_{GS} =$	= 20 V			100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.0		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.6		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> =	: 14 A		4.6	6.0	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> =	= 12 A		6.3	8.5	1
Forward Transconductance	g <sub>FS</sub>	$V_{DS}$ = 15 V, $I_D$ =	: 10 A		13.2		S
CHARGES, CAPACITANCES AND GATE R	ESISTANCE						
Input Capacitance	C <sub>ISS</sub>				2310		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz, } V_{DS} = 24 \text{ V}$		460		1
Reverse Transfer Capacitance	C <sub>RSS</sub>				263		
Total Gate Charge	Q <sub>G(TOT)</sub>				20	30	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}, I_D = 12 \text{ A}$			3.0		
Gate-to-Source Charge	$Q_{GS}$				6.7		
Gate-to-Drain Charge	$Q_{GD}$				8.1		
Gate Resistance	$R_{G}$				0.7		Ω
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t <sub>d(ON)</sub>				20		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> :	= 15 V,		20		]
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 1.0 \text{ A}, R_{L} = 15 \Omega, R_{G} = 3.0 \Omega$			30		
Fall Time	t <sub>f</sub>				31		1
DRAIN-SOURCE DIODE CHARACTERISTI	cs				•	•	•
Forward Diode Voltage	$V_{SD}$	$V_{GS} = 0 \text{ V}, I_S = 7.0 \text{ A}$ $T_J = 25^{\circ}\text{C}$ $T_{J} = 125^{\circ}\text{C}$			0.75	1.0	V
					0.6		1
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 7.0 \text{ A}$			28		ns
Charge Time	ta				14		1
Discharge Time	t <sub>b</sub>				14		1
Reverse Recovery Charge	Q <sub>RR</sub>				23		nC

Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

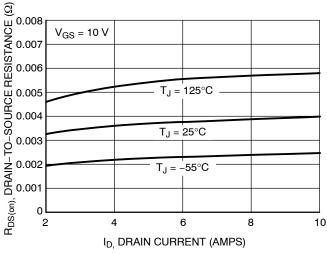
#### **TYPICAL PERFORMANCE CURVES**



24  $V_{DS} = 30 \text{ V}$ 22 ID, DRAIN CURRENT (AMPS) 20 18 16 14 12 10 8  $T_J = 125^{\circ}C$ 6 4  $T_J = 25^{\circ}C$ 2  $T_J = -55^{\circ}C$ 0 2 4 5 1 V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



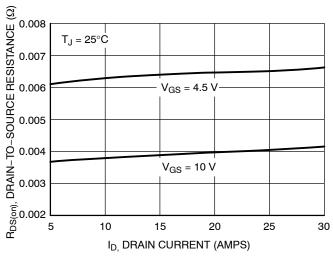
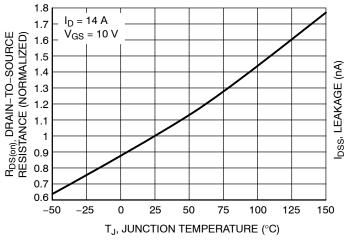


Figure 3. On-Resistance vs. Drain Current

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



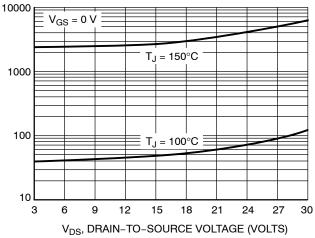


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### **TYPICAL PERFORMANCE CURVES**

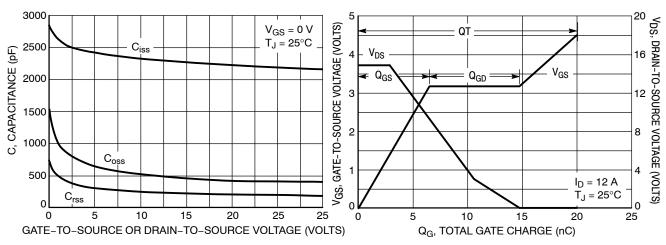


Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

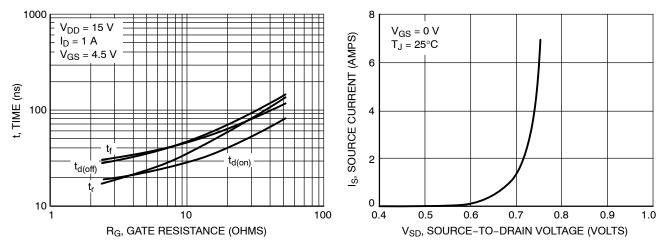


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

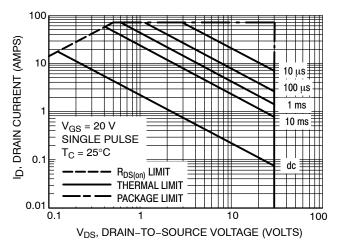


Figure 11. Maximum Rated Forward Biased Safe Operating Area



0.10

SIDE VIEW

DFN5 5x6, 1.27P (SO-8FL) CASE 488AA ISSUE N

**DATE 25 JUN 2018** 

#### NOTES:

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS

	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	0.90	1.00	1.10		
A1	0.00		0.05		
b	0.33	0.41	0.51		
С	0.23	0.23 0.28 0			
D	5.00	5.00 5.15 5.3			
D1	4.70	4.90	5.10		
D2	3.80	4.00	4.20		
E	6.00	6.15	6.30		
E1	5.70	5.90	6.10		
E2	3.45	3.65	3.85		
е		1.27 BSC			
G	0.51	0.575 0.71			
K	1.20	1.20 1.35 1.50			
L	0.51	0.575	0.71		
L1	0.125 REF				
М	3.00	3.40 3.80			
A	0 °		12 °		

#### **GENERIC** MARKING DIAGRAM\*



XXXXXX = Specific Device Code

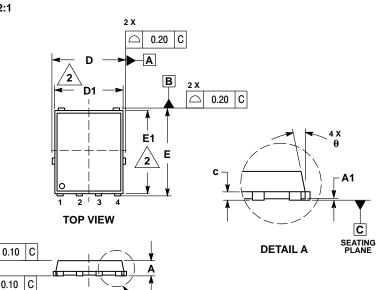
= Lot Traceability

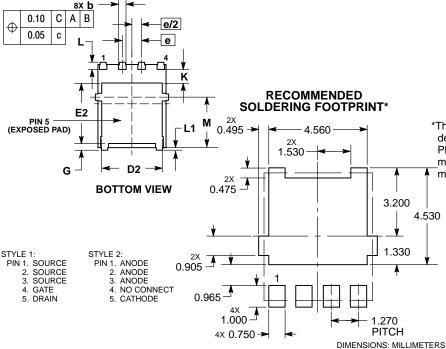
= Assembly Location Α

Υ = Year W = Work Week

ZZ

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present. Some products may not follow the Generic Marking.





**DETAIL A** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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